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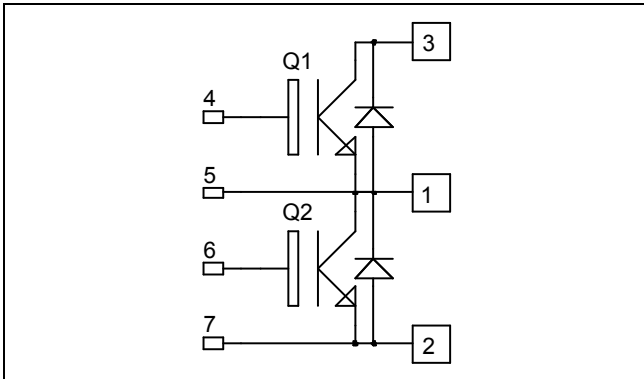
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*Phase leg  
Trench + Field Stop IGBT3  
Power Module*

**$V_{CES} = 1200V$   
 $I_C = 200A @ T_c = 80^\circ C$**


**Application**

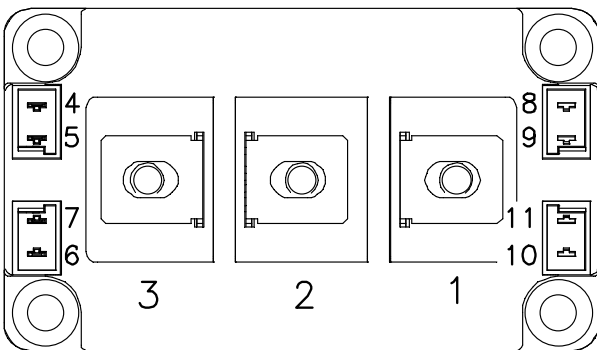
- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

**Features**

- Trench + Field Stop IGBT3 Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- High level of integration
- M6 power connectors

**Benefits**

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive  $T_C$  of  $V_{CEsat}$
- RoHS Compliant


**Absolute maximum ratings**

| Symbol    | Parameter                             | Max ratings         | Unit         |
|-----------|---------------------------------------|---------------------|--------------|
| $V_{CES}$ | Collector - Emitter Breakdown Voltage | 1200                | V            |
| $I_C$     | Continuous Collector Current          | $T_C = 25^\circ C$  | 300          |
|           |                                       | $T_C = 80^\circ C$  | 200          |
| $I_{CM}$  | Pulsed Collector Current              | $T_C = 25^\circ C$  | 400          |
| $V_{GE}$  | Gate - Emitter Voltage                | $\pm 20$            | V            |
| $P_D$     | Maximum Power Dissipation             | $T_C = 25^\circ C$  | 1050         |
| RBSOA     | Reverse Bias Safe Operating Area      | $T_j = 125^\circ C$ | 400A @ 1100V |

**CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on [www.microsemi.com](http://www.microsemi.com)

All ratings @  $T_j = 25^\circ\text{C}$  unless otherwise specified

**Electrical Characteristics**

| Symbol        | Characteristic                       | Test Conditions                                       | Min | Typ | Max | Unit          |
|---------------|--------------------------------------|---|-----|-----|-----|---------------|
| $I_{CES}$     | Zero Gate Voltage Collector Current  | $V_{GE} = 0V, V_{CE} = 1200V$                         |     |     | 500 | $\mu\text{A}$ |
| $V_{CE(sat)}$ | Collector Emitter saturation Voltage | $V_{GE} = 15V$<br>$I_C = 200A$                        | 1.4 | 1.7 | 2.1 | V             |
|               |                                      | $T_j = 25^\circ\text{C}$<br>$T_j = 125^\circ\text{C}$ |     | 2.0 |     |               |
| $V_{GE(th)}$  | Gate Threshold Voltage               | $V_{GE} = V_{CE}, I_C = 8mA$                          | 5.0 | 5.8 | 6.5 | V             |
| $I_{GES}$     | Gate – Emitter Leakage Current       | $V_{GE} = 20V, V_{CE} = 0V$                           |     |     | 400 | nA            |

**Dynamic Characteristics**

| Symbol       | Characteristic               | Test Conditions  | Min                       | Typ                       | Max | Unit          |
|--------------|------------------------------|--|---------------------------|---------------------------|-----|---------------|
| $C_{ies}$    | Input Capacitance            | $V_{GE} = 0V, V_{CE} = 25V$  |                           | 14                        |     | nF            |
| $C_{rss}$    | Reverse Transfer Capacitance | $f = 1MHz$   |                           | 0.6                       |     |               |
| $Q_G$        | Gate charge                  | $V_{GE} = \pm 15V, I_C = 200A$<br>$V_{CE} = 600V$  |                           | 1.9                       |     | $\mu\text{C}$ |
| $T_{d(on)}$  | Turn-on Delay Time           | Inductive Switching ( $25^\circ\text{C}$ )<br>$V_{GE} = \pm 15V$<br>$V_{Bus} = 600V$<br>$I_C = 200A$<br>$R_G = 3.6\Omega$  |                           | 250                       |     | ns            |
| $T_r$        | Rise Time                    |  |                           | 90                        |     |               |
| $T_{d(off)}$ | Turn-off Delay Time          |  |                           | 550                       |     |               |
| $T_f$        | Fall Time                    |  |                           | 130                       |     |               |
| $T_{d(on)}$  | Turn-on Delay Time           | Inductive Switching ( $125^\circ\text{C}$ )<br>$V_{GE} = \pm 15V$<br>$V_{Bus} = 600V$<br>$I_C = 200A$<br>$R_G = 3.6\Omega$ |                           | 300                       |     | ns            |
| $T_r$        | Rise Time                    |  |                           | 100                       |     |               |
| $T_{d(off)}$ | Turn-off Delay Time          |  |                           | 650                       |     |               |
| $T_f$        | Fall Time                    |  |                           | 180                       |     |               |
| $E_{on}$     | Turn on Energy               | $V_{GE} = \pm 15V$<br>$V_{Bus} = 600V$   | $T_j = 125^\circ\text{C}$ | 15                        |     | mJ            |
| $E_{off}$    | Turn off Energy              | $I_C = 200A$<br>$R_G = 3.6\Omega$  |                           | $T_j = 125^\circ\text{C}$ | 35  |               |
| $I_{sc}$     | Short Circuit data           | $V_{GE} \leq 15V; V_{Bus} = 900V$<br>$t_p \leq 10\mu\text{s}; T_j = 125^\circ\text{C}$                                     |                           | 800                       |     | A             |

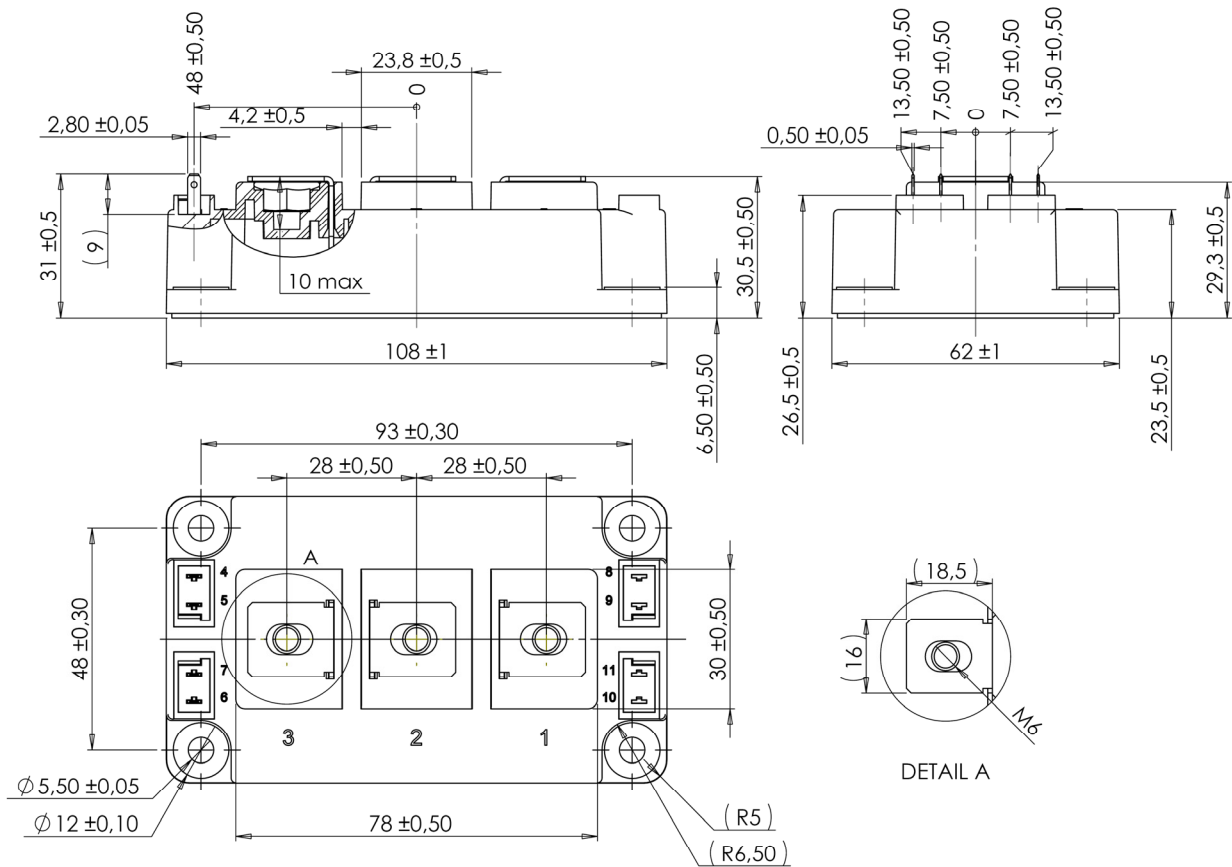
**Reverse diode ratings and characteristics**

| Symbol    | Characteristic                          | Test Conditions   | Min   | Typ | Max  | Unit          |
|-----------|---|---|---|-----|------|---------------|
| $V_{RRM}$ | Maximum Peak Repetitive Reverse Voltage |   | 1200  |     |      | V             |
| $I_{RRM}$ | Maximum Reverse Leakage Current         | $V_R = 1200V$   |   |     | 750  | $\mu\text{A}$ |
|           |   | $T_j = 25^\circ\text{C}$<br>$T_j = 125^\circ\text{C}$       |   |     | 1000 |               |
| $I_F$     | DC Forward Current                      |   |   | 200 |      | A             |
| $V_F$     | Diode Forward Voltage                   | $I_F = 200A$<br>$V_{GE} = 0V$                               | $T_j = 25^\circ\text{C}$<br>$T_j = 125^\circ\text{C}$ | 1.6 | 2.1  | V             |
|           |   |   |   | 1.6 |      |               |
| $t_{rr}$  | Reverse Recovery Time                   | $I_F = 200A$<br>$V_R = 600V$<br>$di/dt = 3500A/\mu\text{s}$ | $T_j = 25^\circ\text{C}$                              | 170 |      | ns            |
|           |   |   | $T_j = 125^\circ\text{C}$                             | 280 |      |               |
| $Q_{rr}$  | Reverse Recovery Charge                 |   | $T_j = 25^\circ\text{C}$                              | 22  |      | $\mu\text{C}$ |
|           |   |   | $T_j = 125^\circ\text{C}$                             | 40  |      |               |
| $E_{rr}$  | Reverse Recovery Energy                 | $T_j = 25^\circ\text{C}$                                    | 9   |     | mJ   |               |
|           |   | $T_j = 125^\circ\text{C}$                                   | 16  |     |      |               |

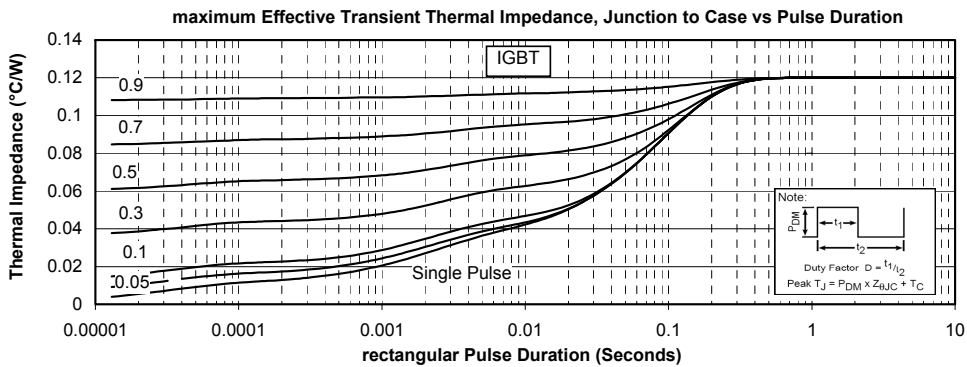
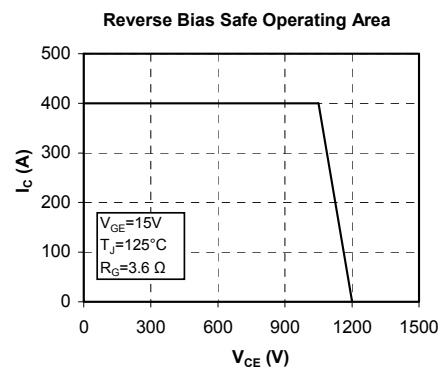
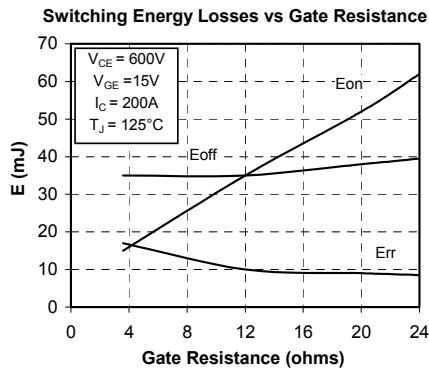
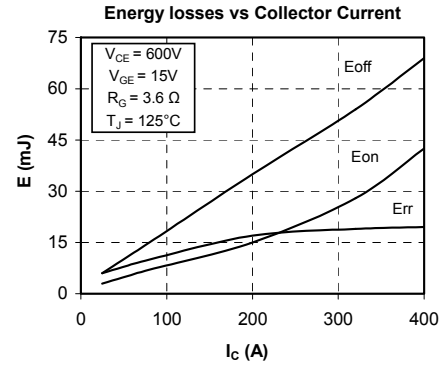
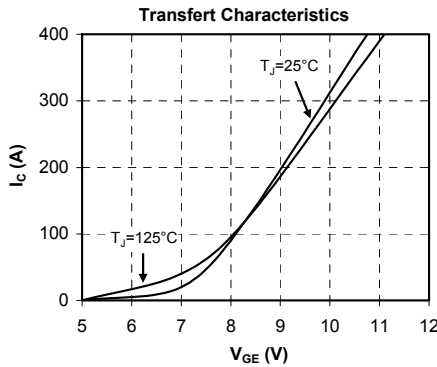
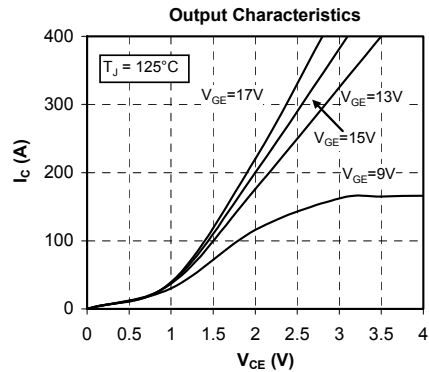
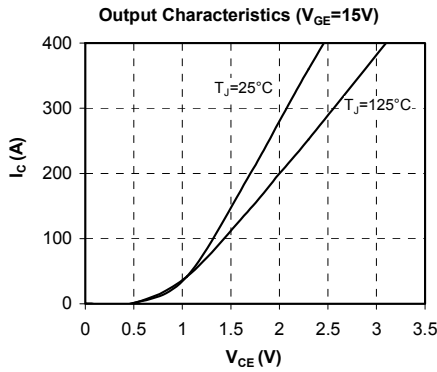
## Thermal and package characteristics

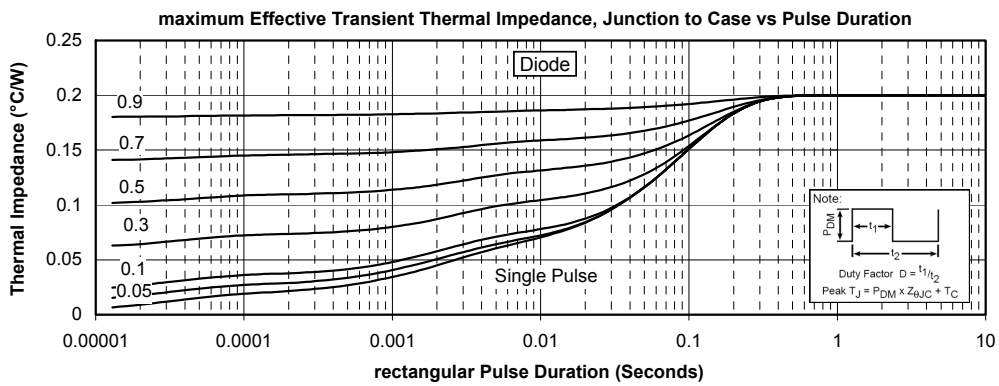
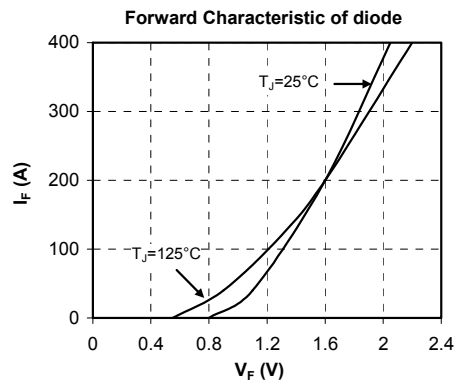
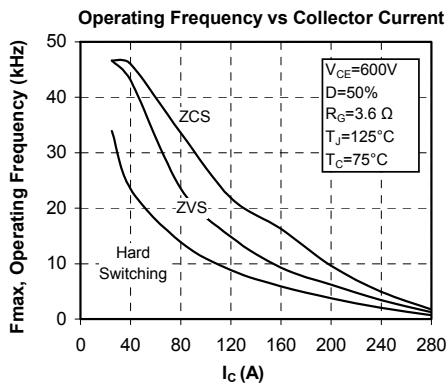
| Symbol            | Characteristic   | Min           | Typ | Max  | Unit |     |
|-------------------|--|---------------|-----|------|------|-----|
| R <sub>thJC</sub> | Junction to Case Thermal Resistance                          | IGBT          |     | 0.12 | °C/W |     |
|                   |  | Diode         |     | 0.20 |      |     |
| V <sub>ISOL</sub> | RMS Isolation Voltage, any terminal to case t=1 min, 50/60Hz | 4000          |     |      | V    |     |
| T <sub>J</sub>    | Operating junction temperature range                         | -40           |     | 150  | °C   |     |
| T <sub>STG</sub>  | Storage Temperature Range                                    | -40           |     | 125  |      |     |
| T <sub>C</sub>    | Operating Case Temperature                                   | -40           |     | 125  |      |     |
| Torque            | Mounting torque  | For terminals | M6  | 3    | 5    | N.m |
|                   |  | To Heatsink   | M6  | 3    | 5    |     |
| Wt                | Package Weight   |               |     | 350  | g    |     |

### D3 Package outline (dimensions in mm)



## Typical Performance Curve





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